Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	der
09/880,191	KATOH, HIDEO	
Examiner	Art Unit	
Quynh H. Nguyen	2642	

SEARCHED				
Class	Subclass	Date	Examiner	
379	433.13 433.12 440	3/6/06	QN	
455	575.1 575.3 575.4	3/6/06	QN	
16	303 330	3/6/06	QN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
379	433.13 433.12 440	3/6/06	QN	
455	575.1 575.3 575.4	3/6/06	QN	
16	303 330	3/6/06	QN	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Searched: East, USPAT, USPGPub	3/6/06	QN
Inventor searched through PALM database	3/6/06	QN
Consulted with Jack Chiang	3/3/06	QN
Consulted with Chuck Mah	3/1/06	QN
Interference searched history printout	3/6/06	QN